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Chappell, B.A.; Chappell, T.I.; Schuster, S.E.; Segmuller, H.M.; Allan, J.W Franch, R.L.; Restle, P.J.;

Solid-State Circuits, IEEE Journal of , Volume: 23 Issue: 1 , Feb. 1988

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2 An integrated CMOS interface for lambda sensor

Civardi, L.; Gatti, U.; Maloberti, F.; Torelli, G.;

Vehicular Technology, IEEE Transactions on , Volume: 43 Issue: 1 , Feb. 1

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